



<b>Searched</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10707647	TSAI ET AL.
	Examiner Kaplan, Hal I	Art Unit 2836

Class	SubClass	Date	Examiner
307	130	06/02/2006	HK
326	68	06/02/2006	HK
327	408	06/02/2006	HK
327	534	06/02/2006	HK

U.S. Patent and Trademark Office	Part of Paper No.: 20060602
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<b>Search Notes</b>  	Application/Control No.  10707647	Applicant(s)/Patent Under Reexamination  TSAI ET AL.
	Examiner Kaplan, Hal I	Art Unit 2836

Notes	Date	Examiner
326/34,68,80,81 (consulted Anh Tran)	06/02/2006	HK
327/408,534 (consulted Quan Tra)	06/02/2006	HK
EAST (US-PGPUB,USPAT,USOCR,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	06/02/2006	HK
EAST (US-PGPUB,USPAT,USOCR,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	06/05/2006	HK
NPL Search - See Search History Printout	06/05/2006	HK
326/34,80,81 (cursory)	06/02/2006	HK

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